

<b>Notice of References Cited</b>	Application/Control No. 10/747,673	Applicant(s)/Patent Under Reexamination EGAMI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,510,381 A	04-1985	Fukatsu, Kunio	194/350
*	B	US-6,198,544 B1	03-2001	Wess et al.	358/296
*	C	US-2002/0152165 A1	10-2002	Dutta et al.	705/43
*	D	US-2002/0152164 A1	10-2002	Dutta et al.	705/43
*	E	US-6,731,778 B1	05-2004	Oda et al.	382/118
*	F	US-2004/0164141 A1	08-2004	Egami et al.	235/379
*	G	US-2005/0073584 A1	04-2005	Enright et al.	348/150
*	H	US-2005/0258236 A1	11-2005	Boyes et al.	235/379
*	I	US-7,014,105 B2	03-2006	Fujioka, Toshinori	235/379
*	J	US-2006/0163797 A1	07-2006	Schmidt et al.	271/145
*	K	US-2007/0145117 A1	06-2007	Throckmorton et al.	235/379
*	L	US-2007/0174194 A1	07-2007	Chappell, Daryl K.	705/45
*	M	US-2007/0181676 A1	08-2007	Mateen et al.	235/381

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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Examiner

Daniel I. Walsh

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2887

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0187485 A1	08-2007	Aas et al.	235/379
*	B	US-2007/0215692 A1	09-2007	VanKirk et al.	235/379
*	C	US-2007/0211148 A1	09-2007	Lev et al.	348/207.99
*	D	US-7,293,699 B2	11-2007	Jenkins et al.	235/379
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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	M	US-			

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	N					
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	P					
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